# RENESAS

# HD74CDCF2510B

140 MHz, 0 to 85°C Operation 3.3-V Phase-lock Loop Clock Driver

> REJ03D0828-1000 (Previous: ADE-205-225H) Rev.10.00 Apr 07, 2006

### Description

The HD74CDCF2510B is a high-performance, low-skew, low-jitter, phase-lock loop clock driver. It uses a phase-lock loop (PLL) to precisely align, in both frequency and phase, the feedback (FBOUT) output to the clock (CLK) input signal. It is specifically designed for use with synchronous DRAMs. The HD74CDCF2510B operates at 3.3 V  $V_{CC}$  and is designed to drive up to five clock loads per output.

Bank of outputs provide ten low-skew, low-jitter copies of the input clock. Output signal duty cycles are adjusted to 50 percent independent of the duty cycle at the input clock. Bank of outputs can be enabled or disabled via the control (G) inputs. When the G inputs are high, the outputs switch in phase and frequency with CLK; when the G inputs are low, the outputs are disabled to the logic-low state.

Unlike many products containing PLLs, the HD74CDCF2510B does not require external RC networks. The loop filter for the PLL is included on-chip, minimizing component count, board space, and cost.

Because it is based on PLL circuitry, HD74CDCF2510B requires a stabilization time to achieve phase lock of the feedback signal to the reference signal. This stabilization time is required, following power up and application of a fixed-frequency, fixed-phase signal at CLK, as well as following any changes to the PLL reference or feedback signals.

#### Features

- Supports PC133 and meets "PC SDRAM registered DIMM specification, Rev. 1.1"
- · Phase-lock loop clock distribution for synchronous DRAM applications
- External feedback (FBIN) pin is used to synchronize the outputs to the clock input
- No external RC network required
- Support spread spectrum clock (SSC) synthesizers
- Supports frequencies up to 140 MHz
- 0 to 85°C operating range
- Ordering Information

Part Name	Package Type	Package Code (Previous code)	Package Abbreviation	Taping Abbreviation (Quantity)
HD74CDCF2510BTEL	TSSOP-24 pin	PTSP0024JB-A (TTP-24DBV)	Т	EL (1,000 pcs / Reel)

### **Function Table**

Inp	uts	Outputs			
G	CLK	1Y (0:9)	FBOUT		
Х	L	L	L		
L	Н	L	Н		
Н	Н	Н	Н		

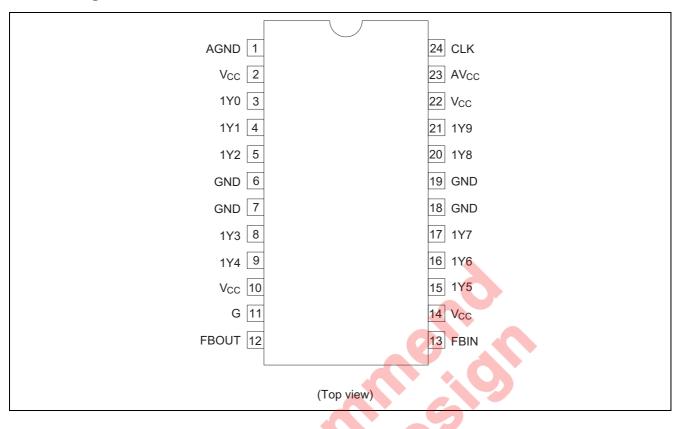
H: High level

L: Low level

X: Immaterial



#### **Pin Arrangement**



### **Absolute Maximum Ratings**

ltem	Symbol	Ratings	Unit	Conditions
Supply voltage	V <sub>cc</sub>	-0.5 to 4.6	V	
Input voltage <sup>*1</sup>	V	-0.5 to 6.5	V	
Output voltage <sup>*1, 2</sup>	Vo	–0.5 to V <sub>CC</sub> +0.5	V	
Input clamp current	I <sub>IK</sub>	_50	mA	V <sub>1</sub> < 0
Output clamp current	I <sub>OK</sub>	±50	mA	$V_{\rm O}$ < 0 or $V_{\rm O}$ > $V_{\rm CC}$
Continuous output current	lo	±50	mA	$V_{\rm O}$ = 0 to $V_{\rm CC}$
Supply current	I <sub>CC</sub> or I <sub>GND</sub>	±100	mA	
Maximum power dissipation at Ta = $55^{\circ}$ C (in still air) <sup>3</sup>	Ρτ	0.7	W	
Storage temperature	T <sub>stg</sub>	-65 to +150	°C	

Notes: Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute maximum rated conditions for extended periods may affect device reliability.

- 1. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.
- 2. This value is limited to 4.6 V maximum.
- 3. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils.

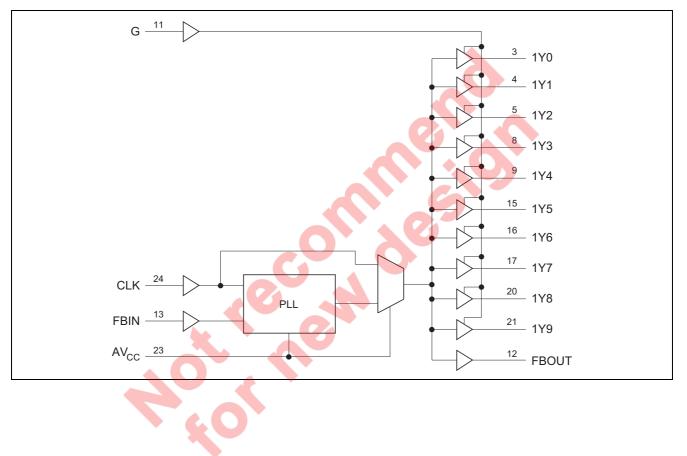


ltem	Symbol	Min	Тур	Max	Unit	Conditions		
Supply voltage	V <sub>CC</sub>	3.0	_	3.6	V			
Input voltage	VIH	2.0	_	—	V			
	VIL	_	_	0.8				
	VI	0	—	V <sub>CC</sub>				
Output current	I <sub>ОН</sub>	_	—	-12	mA			
	I <sub>OL</sub>	_	—	12				
Operating temperature	Ta	0	_	85	°C			

#### **Recommended Operating Conditions**

Note: Unused inputs must be held high or low to prevent them from floating.

## Logic Diagram



### **Pin Function**

Pin name	No.	Туре	Description
CLK	24	I	Clock input. CLK provides the clock signal to be distributed by the
			HD74CDCF2510B clock driver. CLK is used to provide the reference signal to
			the integrated PLL that generates the clock output signals. CLK must have a
			fixed frequency and fixed phase for the PLL to obtain phase lock. Once the
			circuit is powered up and a valid CLK signal is applied, a stabilization time is
		-	required for the PLL to phase lock the feedback signal to its reference signal.
FBIN	13	1	Feedback input. FBIN provides the feedback signal to the internal PLL. FBIN
			must be hard-wired to FBOUT to complete the PLL. The integrated PLL
			synchronizes CLK and FBIN so that there is nominally zero phase error between CLK and FBIN.
G	11	1	
G		1	Output bank enable. G is the output enable for outputs $1Y(0:9)$ . When G is low, outputs $1Y(0:9)$ are disabled to a logic-low state. When G is high, all outputs
			1Y(0.9) are enabled and switch at the same frequency as CLK.
FBOUT	12	0	Feedback output. FBOUT is dedicated for external feedback. It switches at the
гвоот	12	0	same frequency as CLK. When externally wired to FBIN, FBOUT completes
			the feedback loop of the PLL.
1Y(0:9)	3, 4, 5, 8, 9,	0	Clock outputs. These outputs provide low-skew copies of CLK. Output bank
	15, 16, 17,		1Y(0:9) is enabled via the G input. These outputs can be disabled to a logic low
	20, 21		state by deasserting the G control input.
AV <sub>CC</sub>	23	Power	Analog power supply. AV <sub>CC</sub> provides the power reference for the analog
			circuitry. In addition, AV <sub>CC</sub> can be used to bypass the PLL for test purposes.
			When AV <sub>CC</sub> is strapped to ground, PLL is bypassed. This bypass mode is used
			for Hitachi test.
AGND	1	Ground	Analog ground. AGND provides the ground reference for the analog circuitry.
V <sub>CC</sub>	2, 10, 14, 22	Power	Power supply
GND	6, 7, 18,19	Ground	Ground
Electrical	Character	istics	
	Sharacter	131103	

## **Electrical Characteristics**

Item	Symbol	Min	Typ *1	Max	Unit	Test Conditions
Input clamp voltage	Vik	—		-1.2	V	V <sub>CC</sub> = 3 V, I <sub>I</sub> = –18 mA
Output voltage	V <sub>OH</sub>	V <sub>CC</sub> -0.2	9	_	V	$V_{CC}$ = Min to Max, $I_{OH}$ = -100 $\mu$ A
		2.1	—	_		V <sub>CC</sub> = 3 V, I <sub>OH</sub> = -12 mA
		2.4	_	_		V <sub>CC</sub> = 3 V, I <sub>OH</sub> = –6 mA
	V <sub>OL</sub>	—	—	0.2		$V_{CC}$ = Min to Max, $I_{OL}$ = 100 $\mu$ A
		<b>—</b>	—	0.8	]	V <sub>CC</sub> = 3 V, I <sub>OL</sub> = 12 mA
·		—	—	0.55	]	V <sub>CC</sub> = 3 V, I <sub>OL</sub> = 6 mA
Input current	lin	—	—	±5	μΑ	$V_{CC}$ = 3.6 V, $V_{IN}$ = $V_{CC}$ or GND
Quiescent supply current	Icc	—	—	10	μΑ	$AV_{CC} = GND, V_{CC} = 3.6 V,$
						$V_I = V_{CC}$ or GND, $I_O = 0$
	$\Delta I_{CC}$	—	_	500	μΑ	$AV_{CC}$ = GND, $V_{CC}$ = 3.3 to 3.6 V
						One input at V <sub>CC</sub> –0.6 V,
						Other inputs at V <sub>CC</sub> or GND
Input capacitance	CIN	_	4	_	pF	$V_{CC}$ = 3.3 V, $V_{I}$ = $V_{CC}$ or GND
Output capacitance	Co	_	6	_	pF	$V_{CC}$ = 3.3 V, $V_{O}$ = $V_{CC}$ or GND

Note: 1. For conditions shown as Min or Max, use the appropriate value specified under recommended operating conditions.

### **Switching Characteristics**

 $(C_L = 25 \text{ pF}, \text{Ta} = 0 \text{ to } 85^{\circ}\text{C})$ 

ltem	Symbol	V <sub>CC</sub> = 3.3 V±0.3 V			Unit	From (Input)	To (Output)
nem	Symbol	Min	Тур	Max	Unit	From (Input)	
Phase error time	t <sub>pe</sub>	-125	_	125	ps	CLKIN↑	FBIN↑
						= 133 MHz	
Between output pins skew *1	t <sub>sk (O)</sub>	_	_	150	ps	Any Y or FBOUT,	Any Y or FBOUT
						F (clkin =	
						133 MHz)	
Cycle to cycle jitter		-75		75	ps	F (clkin =	Any Y or FBOUT
						133 MHz)	
Duty cycle		45	_	55	%	F (clkin =	Any Y or FBOUT
						133 MHz)	
Slew rate		5.0	_	1.0	volts/ns		Any Y or FBOUT
Analog power supply rejection	Vapsr *2	100			$mV_{P-P}$		AV <sub>CC</sub>
(DC to 10 MHz)							

Notes: The specifications for parameters in this table are applicable only after any appropriate stabilization time has elapsed.

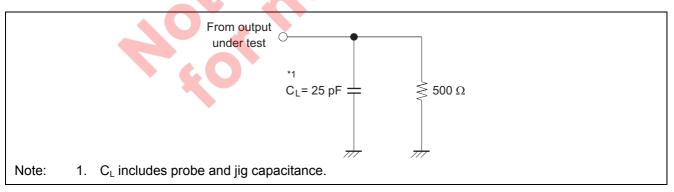
- 1. The t<sub>sk(O)</sub> specification is only valid for equal loading of all outputs.
- 2. This parameter is characterized but not tested.

#### **Timing Requirements**

Item	Symbol	Min	Max	Unit	Test Conditions
Input clock frequency	f <sub>clock</sub>	50	140	MHz	
Input clock duty cycle		40	60	%	
Stabilization time <sup>*1</sup>			1	ms	After power up

Note: 1. Time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal. In order for phase lock to be obtained, a fixed-frequency, fixed-phase reference signal must be present at CLK. Until phase lock is obtained, the specifications for propagation delay and skew parameters given in the switching characteristics table are not applicable.

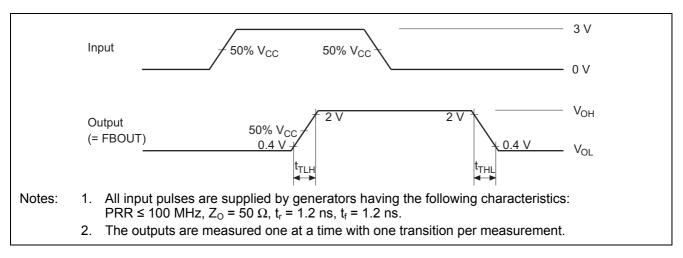
### **Test Circuit**



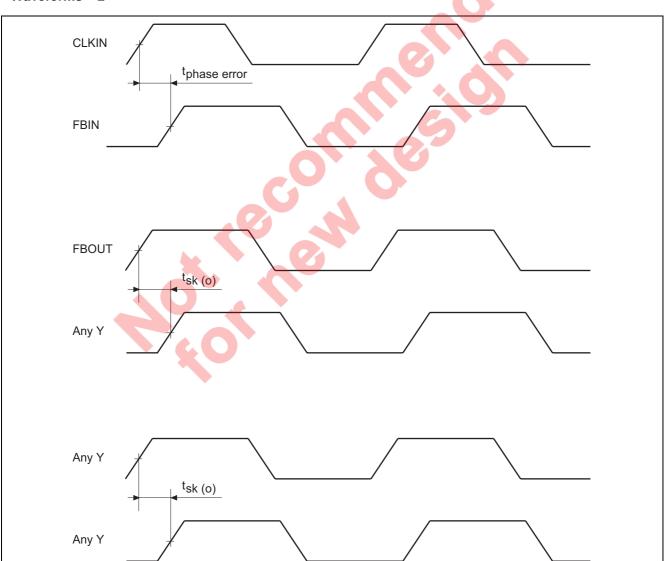


#### HD74CDCF2510B

#### Waveforms - 1

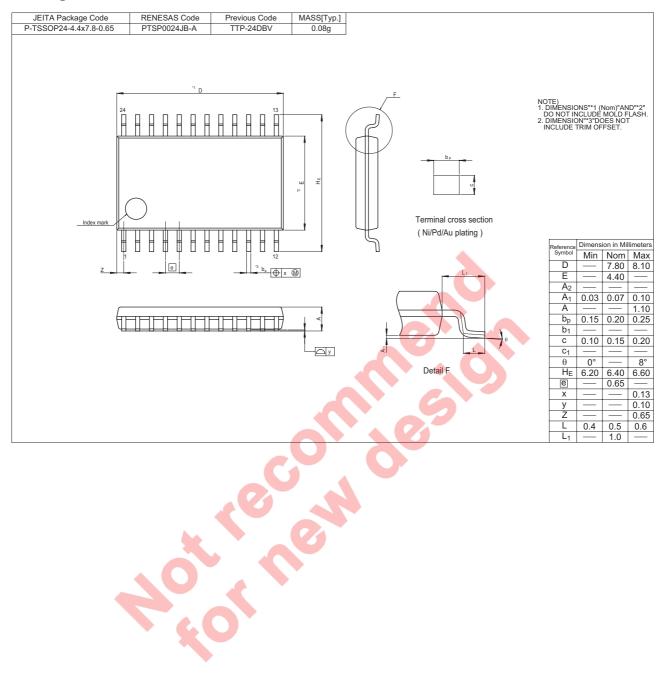








### **Package Dimensions**





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